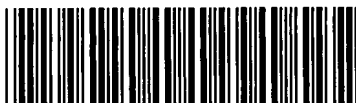


**Search Notes**

Application/Control No.

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shih-wen hsieh

Applicant(s)/Patent under  
Reexamination

KUSUNOKI ET AL.

Art Unit

2861

**SEARCHED**

Class	Subclass	Date	Examiner
347	29,30,45 100	6/16/2007	SWH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR